

Orientational order in stretch-aligned single wall carbon nanotubes/polymer photoluminescent films

C. Zamora-Ledezma^{1,2}, C. Blanc¹, E. Anglaret^{*1}

1.- Laboratoire des Colloïdes, Verres et Nanomatériaux, UMR CNRS 5587, Université Montpellier 2, Montpellier, 34095, France.
 2.- Instituto Venezolano de Investigaciones Científicas, Laboratorio de Física de la Materia Condensada, Caracas, Venezuela.

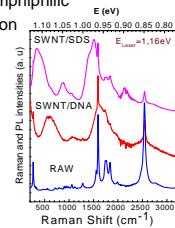
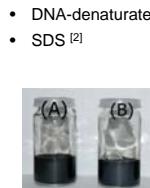
* Corresponding author: eric.anglaret@lcvn.univ-montp2.fr

GOALS

1. Measure the orientational order of individualized single wall carbon nanotubes (SWNT) dispersed in polyvinylalcohol (PVA) films as a function of the film elongation.
2. Compare the experimental results with a simple geometric model.
3. Validate an accurate method to measure the scalar orientational parameter order in anisotropic SWNT materials

SWNT-HipCo bundles exfoliation

- Non covalent adsorption of amphiphilic molecules in water, tip-sonication



Photoluminescence as an evidence for exfoliation [3]

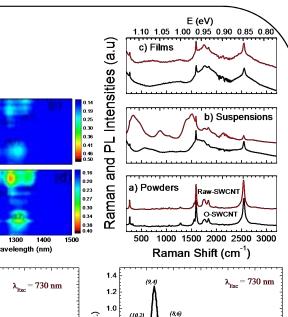
SWNT/PVA FILMS PREPARATION

- Mixing 8 ml of aqueous nanotubes suspension with 8 ml of a PVA solution (PVA 10 wt.-%)

Drying and formation of PVA films



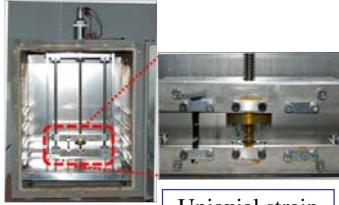
Only DNA-stabilized SWNT Films remain homogeneous



Photoluminescence as an evidence for exfoliation [3]

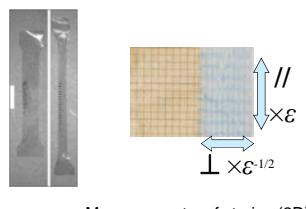
Stretching and Measurements

- Hot drawing of PVA films at T=120°C



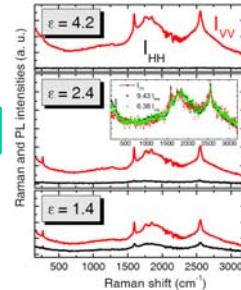
Uniaxial strain

How to measure the deformation



- Measurements of strains (2D)

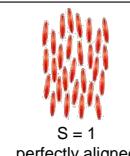
Raman spectroscopy and photoluminescence



SWNT orientational order

Typical scalar order parameter

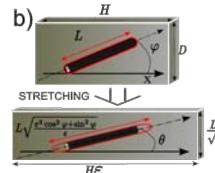
$$S = \frac{1}{2} \langle 3 \cos^2 \theta - 1 \rangle$$



A simple geometric Model

$$(x, y, z) \rightarrow \left(\varepsilon x, \frac{y}{\sqrt{\varepsilon}}, \frac{z}{\sqrt{\varepsilon}} \right)$$

$$p(\theta)d(\theta) = p(\varphi)d(\varphi) = \sin \varphi d\varphi$$



$$\tan \theta = \frac{D}{H\varepsilon^{3/2}} = \frac{\tan \varphi}{\varepsilon^{3/2}}$$

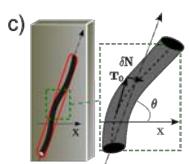
$$\cos^2 \theta = \frac{\varepsilon^3}{\varepsilon^3 + \tan^2 \varphi}$$

$$S_g = \int_0^{\frac{\pi}{2}} \frac{3 \cos^2 \theta - 1}{2} p(\theta) d\theta$$

$$= \frac{\sqrt{\varepsilon^3 - 1}(2\varepsilon^3 + 1) - 3\varepsilon^3 \arctan \sqrt{\varepsilon^3 - 1}}{2(\varepsilon^3 - 1)^{3/2}}$$

Amended model

$$S_c \approx S_g + \frac{3}{2} \int_{\varphi_e}^{\frac{\pi}{2}} \frac{\tan^2 \varphi - 2\varepsilon^3}{\varepsilon^3 + \tan^2 \varphi} \left(1 - \frac{L(\varepsilon, \varphi)}{L} \right) \sin \varphi d\varphi$$



Conclusions

1. S has been measured by Raman and Photoluminescence spectroscopies.
2. A good agreement is found with a simple model considering only stretching-induced geometric changes of the films.
3. We developed a simple and accurate method to measure order parameter in SWNT composites

